

## Qualification Results Summary of ADSP-21060 CQFP at Rochester Electronics

| QUALIFICATION PLAN / STATUS    |                           |             |             |
|--------------------------------|---------------------------|-------------|-------------|
| TEST                           | SPECIFICATION             | SAMPLE SIZE | RESULT      |
| Temperature Cycle (TC)         | JEDEC <i>JESD22-A104</i>  | 3 x 32      | <b>Pass</b> |
| High Temperature Storage (HTS) | JEDEC <i>JESD 22-A103</i> | 1 x 32      | <b>Pass</b> |
| Group D: Sub 1                 | MIL-STD-883, <i>M5005</i> | 1 x 15      | <b>Pass</b> |
| Group D: Sub 4                 | MIL-STD-883, <i>M5005</i> | 1 x 15      | <b>Pass</b> |
| Group D: Sub 6                 | MIL-STD-883, <i>M5005</i> | 1 x 3       | <b>Pass</b> |
| Solderability Test             | JEDEC <i>JESD22-B102</i>  | 3 x 1       | <b>Pass</b> |